Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
09/636,783	YAMASHITA ET AL.	
Examiner	Art Unit	
HOAN C. NGUYEN	2871	

SEARCHED					
Class	Subclass	Date	Examiner		
345	155	8/24/2005	CHN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
update search in US_PGPUB, USPAT, EPO and JPO	8/24/2005	CHN
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